Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 286669US0PCT		SERIAL NO. 10/576,257					
				APPLICANT					
LIST OF REFERENCES CITED BY APPLICANT Nobukazu TANAKA, et al.									
				FILING DATE		GROUP			
				April 27, 2007		1612			
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FOREIGN PATENT DOCUMENTS									
		DOCUMENT NUMBER	DATE	COUNTRY		TRANS YES		LATION NO	
	AO	5-310558	11/22/93	Japan w/English Abstract					
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	AW	Japanese Office Action dated November 9, 2010 as received in the corresponding Japanese Patent Application No. 2005-514774							
	AX								
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	AY								
	ΑZ				Additional References sheet(s) attached				
Examiner					<u> </u>	Date Considered			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									